

# PITTING CORROSION MEASUREMENT USING 3D PROFILOMETRY



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# **INTRO:**

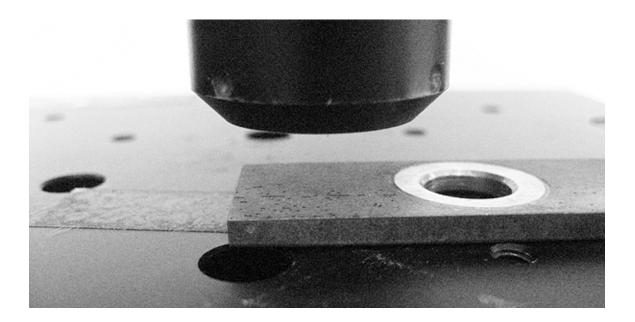
In the form of holes, pitting corrosion is localized and can penetrate into materials very quickly and is one of the most frequent forms of corrosion in stainless steels. The quantification of pitting corrosion has been a main focus of study in recent years. Pitting corrosion is quantified in different ways e.g. average pit depth, maximum pit depth, volume etc.

#### **IMPORTANCE OF 3D NON CONTACT PROFILOMETER FOR PITTING STUDY**

Unlike other techniques such as touch probes or interferometry, the 3D Non Contact Profilometer, using axial chromatism, can measure nearly any surface, sample sizes can vary widely due to open staging and there is no sample preparation needed. Nano through macro range is obtained during surface profile measurement with zero influence from sample reflectivity or absorption, has advanced ability to measure high surface angles and there is no software manipulation of results. Easily measure any material: transparent, opaque, specular, diffusive, polished, rough etc. The technique of the Non Contact Profilometer provides an ideal, broad and user friendly capability to maximize surface studies when pitting analysis will be needed; along with the benefits of combined 2D & 3D capability.

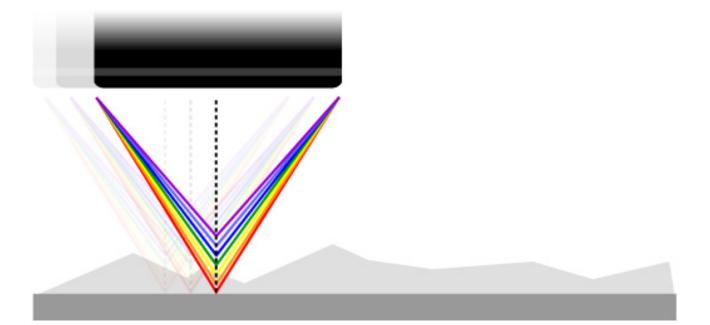
#### **MEASUREMENT OBJECTIVE**

In this application the Nanovea ST400 Profilometer is used to measure the surface of a corrosion pitted stainless steel coupon. The area measured was selected at random, and assumed large enough in that it could be extrapolated to make assumptions about a much larger surface. Density, area, volume, size and shape will be used here to quantify the level of corrosion.



## **MEASUREMENT PRINCIPLE:**

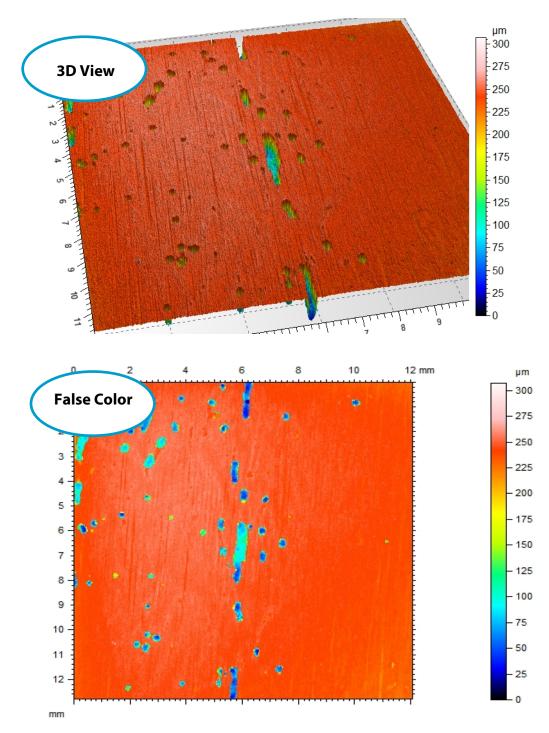
The axial chromatism technique uses a white light source, where light passes through an objective lens with a high degree of chromatic aberration. The refractive index of the objective lens will vary in relation to the wavelength of the light. In effect, each separate wavelength of the incident white light will re-focus at a different distance from the lens (different height). When the measured sample is within the range of possible heights, a single monochromatic point will be focalized to form the image. Due to the confocal configuration of the system, only the focused wavelength will pass through the spatial filter with high efficiency, thus causing all other wavelengths to be out of focus. The spectral analysis is done using a diffraction grating. This technique deviates each wavelength at a different position, intercepting a line of CCD, which in turn indicates the position of the maximum intensity and allows direct correspondence to the Z height position.



Unlike the errors caused by probe contact or the manipulative Interferometry technique, White light Axial Chromatism technology measures height directly from the detection of the wavelength that hits the surface of the sample in focus. It is a direct measurement with no mathematical software manipulation. This provides unmatched accuracy on the surface measured because a data point is either measured accurately without software interpretation or not at all. The software completes the unmeasured point but the user is fully aware of it and can have confidence that there are no hidden artifacts created by software guessing. Nanovea optical pens have zero influence from sample reflectivity or absorption. Variations require no sample preparation and have advanced ability to measure high surface angles. Capable of large Z measurement ranges. Measure any material: transparent/opaque, specular/diffusive or polished/rough.

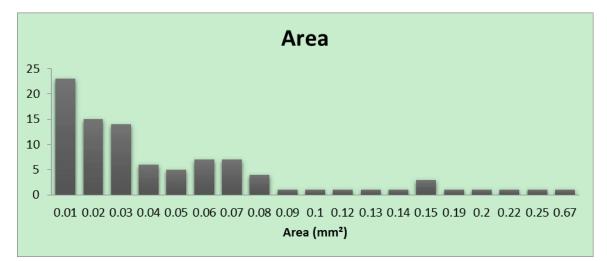
## **RESULTS:** 3D Surface

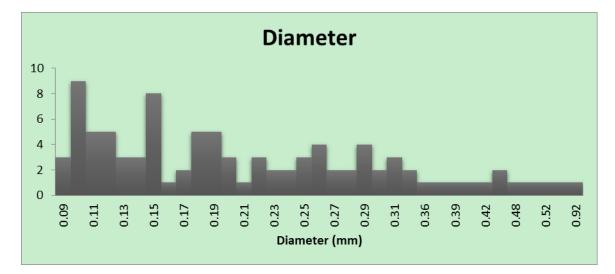
The 3D View and False Color View of a randomly selected area on the sample surface after pitting corrosion show pits of various shape and depth. It provides users a straightforward tool to directly observe the distribution and morphology of the pits from different angles. Several pits exhibit an elongated shape parallel to the direction of the machine marks, indicating the importance of surface finishing to the corrosion resistance of metals.

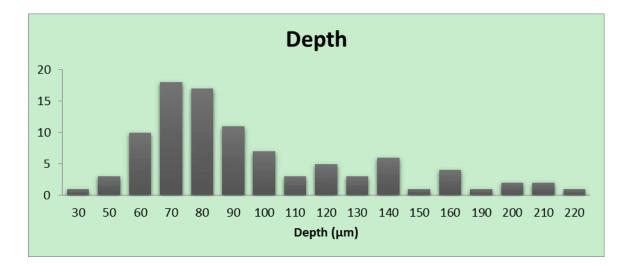


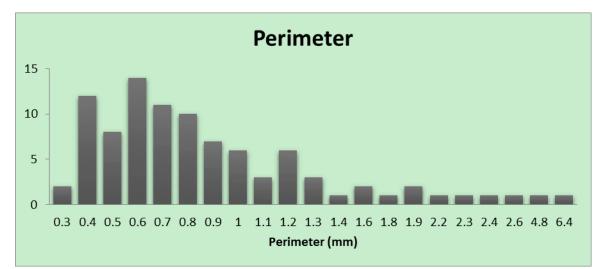
### **RESULTS:** 2D Surface Analysis

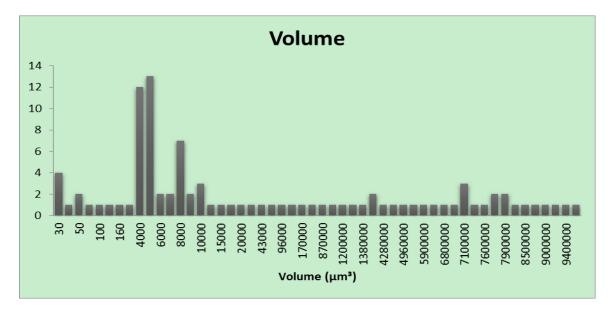
The pits can be quantitified in numerious ways using built-in software tools as shown in the following figures as examples. It can be observed that ~55% of the pits have an open area size below 0.03 mm<sup>2</sup> and pit depth ranging from 60 to 90  $\mu$ m. One quarter of the pits possess a volume of 4000-5000  $\mu$ m<sup>2</sup>. Such statistical information allows us to compare the pitting resistance of different materials and provide more insight in the mechanism of pit formation and development.











# **CONCLUSION:**

In this application, we have shown how the Nanovea 3D Non Contact Profilometer can precisely characterize the corrosion pitted surface of stainless steel. The data shows a measurement of 95 pits found in the area measured with a density of 0.3110 pits/mm<sup>2</sup>. The pit density, together with the statistical information such as the volume loss and pit size distribution generated by the software, could be used to compare the pitting resistance against other test coupons developed under different conditions. The data shown here represents only a portion of the calculations available in the analysis software, however this statistical data can be calculated over the entire surface measure, or each pit could be analyzed individually by selecting one pit.

Learn more about the Nanovea Profilometer or Lab Services